## Application/Control No. Applicant(s)/Patent Under Reexamination 10/815,843 AHN ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 A. Sefer 2826 U.S. PATENT DOCUMENTS Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY US-Α US-В US-C US-D US-Ε US-F US-G US-Н US-1. US-US-Κ US-US-М FOREIGN PATENT DOCUMENTS Document Number Date Country . Classification Name Country Code-Number-Kind Code MM-YYYY JP 2002-196703 07-2002 Japan Kasai et al Ν 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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